

## General Description

The MY3401 is the high cell density trenched P-CH MOSFET, which provide excellent  $R_{DS(ON)}$  and efficiency for most of the small power switching and load switch applications.

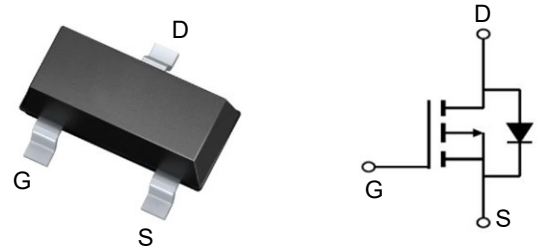


## Features

|                                     |      |           |
|-------------------------------------|------|-----------|
| $V_{DSS}$                           | -20  | V         |
| $I_D$                               | -2.5 | A         |
| $R_{DS(ON)}$ (at $V_{GS} = -10V$ )  | 90   | $m\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = -4.5V$ ) | 115  | $m\Omega$ |

## Application

- Green Device Available
- Super Low Gate Charge
- Excellent  $CdV/dt$  effect decline



## Package Marking and Ordering Information

| Product ID | Pack   | Marking | Qty(PCS) |
|------------|--------|---------|----------|
| MY3401     | SOT-23 | A19T    | 3000     |

## Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise noted)

| Parameter  |  | Symbol          | Limit      | Unit                      |
|--|--|-----------------|------------|---------------------------|
| Drain-Source Voltage                                 |  | $V_{DS}$        | -20        | V                         |
| Gate-Source Voltage                                  |  | $V_{GS}$        | $\pm 10$   | V                         |
| Drain Current <sup>a</sup>                           | $T_C=25^\circ\text{C}$                   | $I_D$           | -2.5       | A                         |
|  | $T_C=25^\circ\text{C}, t \leq 5\text{s}$ |                 | -2.8       |                           |
|  | $T_C=70^\circ\text{C}$                   |                 | -1.1       |                           |
| Drain Current – Pulsed <sup>a</sup>                  |  | $I_{DM}$        | -8.0       | A                         |
| Power Dissipation ( $T_C=25^\circ\text{C}$ )         |  | $P_D$           | 1.56       | W                         |
| Power Dissipation – Derate Above $25^\circ\text{C}$  |  |                 | 0.012      |                           |
| Storage Temperature Range                            |  | $T_{STG}$       | -55 ~ +150 | $^\circ\text{C}$          |
| Operating Junction Temperature Range                 |  | $T_J$           | -55 ~ +150 | $^\circ\text{C}$          |
| Thermal Resistance, Junction-to-Ambient <sup>1</sup> |  | $R_{\theta JA}$ | 100        | $^\circ\text{C}/\text{W}$ |

**Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

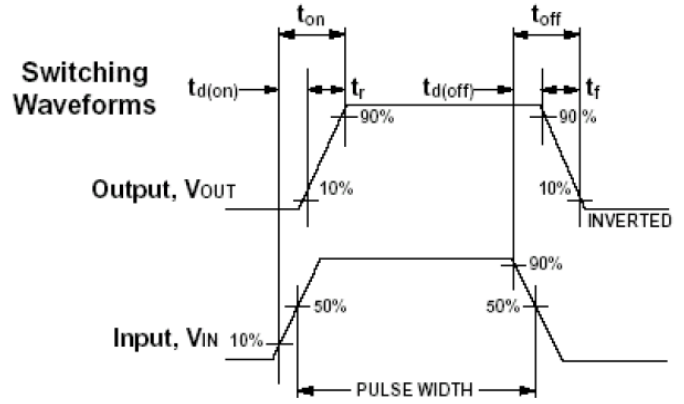
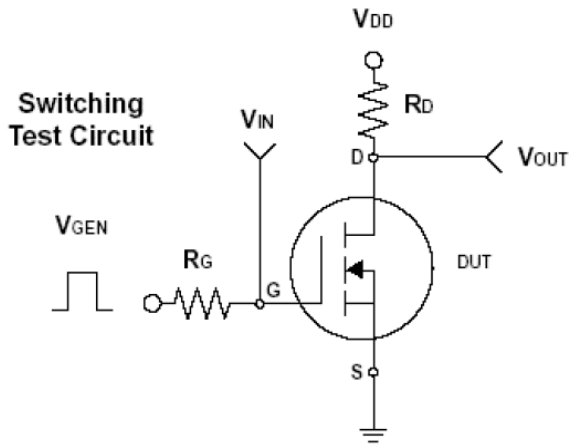
| Parameter  | Symbol              | Condition  | Min  | Typ | Max  | Unit |
|--|---------------------|--|------|-----|------|------|
| <b>Off Characteristics</b>                             |                     |  |      |     |      |      |
| Drain-Source Breakdown Voltage                         | BV <sub>DSS</sub>   | V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA  | -20  | --- | ---  | V    |
| Zero Gate Voltage Drain Current                        | I <sub>DSS</sub>    | T <sub>J</sub> =25°C<br>V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V                         | ---  | --- | -1   | μA   |
| Gate-Body Leakage                                      | I <sub>GSS</sub>    | V <sub>GS</sub> =±10V, V <sub>DS</sub> =0V   | ---  | --- | ±100 | nA   |
| <b>On Characteristics <sup>a</sup></b>                 |                     |  |      |     |      |      |
| Gate Threshold Voltage                                 | V <sub>GS(th)</sub> | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                  | -0.3 | --- | -1.0 | V    |
| Drain-Source On-State Resistance                       | R <sub>DS(on)</sub> | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2.0A  | ---  | 90  | 125  | mΩ   |
|  |                     | V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-1.5A  | ---  | 115 | 165  |      |
|  |                     | V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-1.0A  | ---  | 170 | 250  |      |
| Forward Transconductance                               | g <sub>fs</sub>     | V <sub>DS</sub> =5V, I <sub>D</sub> =1A  |      |     |      | S    |
| <b>Drain-Source Diode Characteristics <sup>a</sup></b> |                     |  |      |     |      |      |
| Continuous Source Current                              | I <sub>S</sub>      | V <sub>G</sub> =V <sub>D</sub> =0V, Force Current  | ---  | --- | -2.0 | A    |
| Diode Forward Voltage                                  | V <sub>SD</sub>     | V <sub>GS</sub> =0V, I <sub>S</sub> =-1A   | ---  | --- | -1.3 | V    |
| <b>Dynamic Characteristics <sup>b</sup></b>            |                     |  |      |     |      |      |
| Input Capacitance                                      | C <sub>iss</sub>    | V <sub>DS</sub> =-15V,<br>V <sub>GS</sub> =0V, F=1MHz                                      | ---  |     |      | pF   |
| Output Capacitance                                     | C <sub>oss</sub>    |  | ---  |     |      |      |
| Reverse Transfer Capacitance                           | C <sub>rss</sub>    |  | ---  |     |      |      |
| <b>Switching Characteristics <sup>b</sup></b>          |                     |  |      |     |      |      |
| Total Gate Charge                                      | Q <sub>g</sub>      | V <sub>DS</sub> =-10V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2A                         | ---  |     |      | nC   |
| Gate-Source Charge                                     | Q <sub>gs</sub>     |  | ---  |     |      |      |
| Gate-Drain Charge                                      | Q <sub>gd</sub>     |  | ---  |     |      |      |
| Turn-On Delay Time                                     | T <sub>d(on)</sub>  | V <sub>DD</sub> =-10V, V <sub>GS</sub> =-4.5V,<br>R <sub>G</sub> =25Ω, I <sub>D</sub> =-1A | ---  |     |      | ns   |
| Rise Time  | T <sub>r</sub>      |  | ---  |     |      |      |
| Turn-Off Delay Time                                    | T <sub>d(off)</sub> |  | ---  |     |      |      |
| Fall Time  | T <sub>f</sub>      |  | ---  |     |      |      |

Notes: a. Repetitive Rating: Pulsed width limited by maximum junction temperature.

b. Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%.

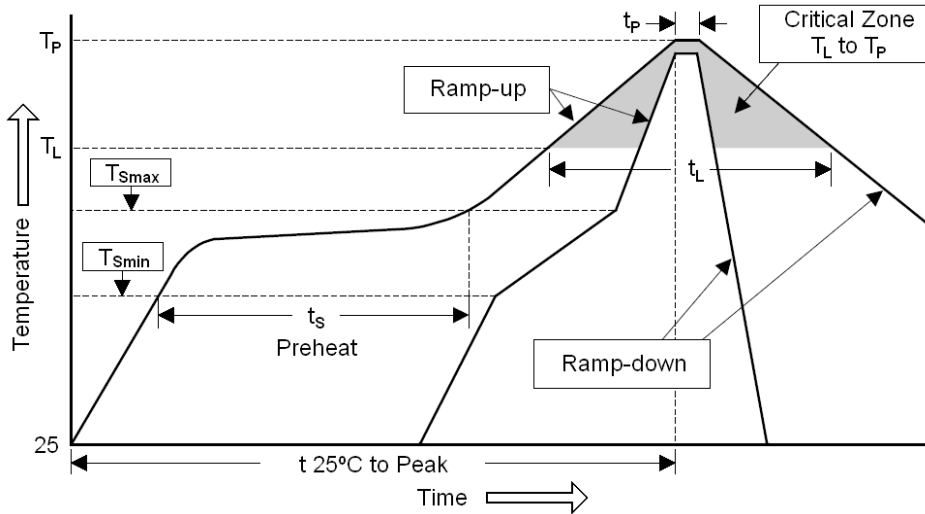
c. Guaranteed by design, not subject to production testing.

**Switching Time Test Circuit and Waveforms**



**Soldering Methods For Products**

1. Storage environment : Temperature=10°C~35°C, Humidity=65%±15%
2. Reflow soldering of surface mount devices



**Figure : Temperature Profile**

| Profile Feature                                      | Sn-Pb Eutectic Assembly | Pb-Free Assembly |
|--|-------------------------|------------------|
| Average ramp-up rate ( $T_L$ to $T_P$ )              | < 3°C/sec               | < 3°C/sec        |
| Preheat  |                         |                  |
| - Temperature Min ( $T_{Smin}$ )                     | 100°C                   | 100°C            |
| - Temperature Max ( $T_{Smax}$ )                     | 150°C                   | 200°C            |
| - Time (Min to Max) ( $t_s$ )                        | 60 ~ 120 sec            | 60 ~ 180 sec     |
| $T_{Smax}$ to $T_L$                                  |                         |                  |
| - Ramp-up rate                                       | < 3°C/sec               | < 3°C/sec        |
| Time maintained above:                               |                         |                  |
| - Temperature ( $T_L$ )                              | 183°C                   | 217°C            |
| - Time ( $t_L$ )                                     | 60 ~ 150 sec            | 60 ~ 150 sec     |
| Peak Temperature ( $T_P$ )                           | 240°C +0/-5°C           | 260°C +0/-5°C    |
| Time within 5°C of actual Peak Temperature ( $t_p$ ) | 10 ~ 30 sec             | 20 ~ 40 sec      |
| Ramp-down rate                                       | < 6°C/sec               | < 6°C/sec        |
| Time 25°C to Peak Temperature                        | < 6 minutes             | < 8 minutes      |

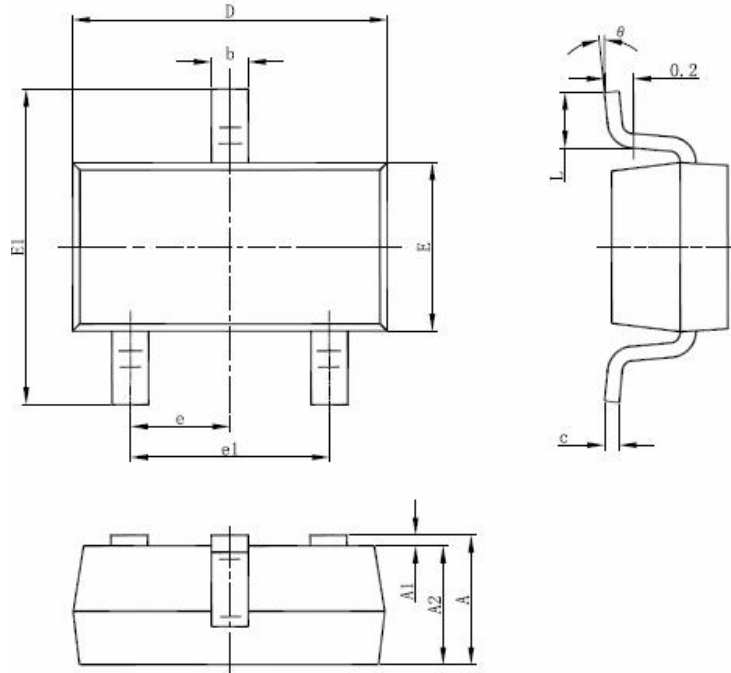
3. Flow (wave) soldering (solder dipping)

| Product         | Peak Temperature | Dipping Time |
|-----------------|------------------|--------------|
| Pb devices      | 245°C ±5°C       | 5sec ±1sec   |
| Pb-Free devices | 260°C +0/-5°C    | 5sec ±1sec   |

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- MOS 管电路是静电敏感元器件，且对生产环境要求较严，建议在存放、运输及生产操作时一定要避免静电干扰。
- 由于每个 PCB 版图和设计都不同，每个 MOSFET 的结构也不同，因此，没有通用的流程可用来计算每个应用的最大允许电流，建议在选用 MOS 管器件时考虑到余量，以免 MOS 管因此而造成损坏。

**Package Mechanical Data-SOT-23**



| Symbol | Dimensions In Millimeters |       | Dimensions In Inches |       |
|--------|---------------------------|-------|----------------------|-------|
|        | Min                       | Max   | Min                  | Max   |
| A      | 1.050                     | 1.250 | 0.041                | 0.049 |
| A1     | 0.000                     | 0.100 | 0.000                | 0.004 |
| A2     | 1.050                     | 1.150 | 0.041                | 0.045 |
| b      | 0.300                     | 0.500 | 0.012                | 0.020 |
| c      | 0.100                     | 0.200 | 0.004                | 0.008 |
| D      | 2.820                     | 3.020 | 0.111                | 0.119 |
| E      | 1.500                     | 1.700 | 0.059                | 0.067 |
| E1     | 2.650                     | 2.950 | 0.104                | 0.116 |
| e      | 0.950(BSC)                |       | 0.037(BSC)           |       |
| e1     | 1.800                     | 2.000 | 0.071                | 0.079 |
| L      | 0.300                     | 0.600 | 0.012                | 0.024 |
| θ      | 0°                        | 8°    | 0°                   | 8°    |